

CORRECTED INFORMATION DISCLOSURE STATEMENT BY APPLICANT		Application No.	10/563,705
<i>(Multiple sheets used when necessary)</i>		Filing Date	January 5, 2006
		First Named Inventor	Hada et al.
		Art Unit	1795
SHEET 1 OF 2		Examiner	John S Y Chu
		Attorney Docket No.	SHIGA7.038APC

U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number <i>Number - Kind Code (if known)</i> Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
1		US 2002/0048720	04-25-2002	Sasaki et al.	
2		US 2003/0087183	05-08-2003	Nishi et al.	
3		US 2003/0113661	06-19-2003	Uetani et al.	
4		US 2004/0058269	03-25-2004	Hada et al.	
5		5,968,713	10-19-1999	Nozaki et al.	
6		6,004,720	12-21-1999	Takechi et al.	
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Examiner Initials	Cite No.	Foreign Patent Document <i>Country Code-Number-Kind Code</i> Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T ¹
24		JP H04-039665	02-10-1992	Fujitsu Ltd		✓ Abstract
25		JP H05-346668	12-27-1993	Fujitsu Ltd		✓ Abstract

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /JSC/

Examiner Signature	/John Chu/	Date Considered	04/22/2009
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*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ¹

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